

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination JUNG ET AL.	
		Examiner Shi K. Li	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,925,266 B1	08-2005	Muller, Claus-Georg	398/196
*	B	US-6,980,742 B1	12-2005	Liden et al.	398/85
*	C	US-2004/0091265 A1	05-2004	Kim et al.	398/072
	D	US-			
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	K	US-			
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	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	European search report for Application EP 04 01 1315, dated 21 March 2006 (provided by Applicant filed 4/13/2006).
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